Search Notes



Application/Control No.	Applicant(s)/Patent Under Reexamination
09630024	FARLEY ET AL.
Examiner	Art Unit
RICHARD CHAN	2618

SEARCHED				
Class	Subclass	Date	Examiner	
455	518, 434, 450, 453	1/28/11	RC	
714	4, 228	6/1/12	RC	

SEARCH NOTES		
Search Notes	Date	Examiner
Consulted Primary yuwen pan regarding proposed added limitation proposed by the applicant after final.	1/18/12	RC
Updated EAST search report	6/1/12	RC

INTERFERENCE SEARCH				
Class	Subclass	Date	Examiner	
455	434,, 450, 453, 518	6/1/12	RC	

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